Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | TAKAGI ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0075980	04-2003	YOSHIDA et al.	307/9.1
*	В	US-6,914,765	07-2005	Nakamura et al.	361/160
*	C	US-2002/0054473	05-2002	Yamane, Shigeki	361/601
*	D	US-2002/0141143	10-2002	Yamane, Shigeki	361/601
*	E	US-6,724,627	04-2004	Onizuka et al.	361/704
*	F	US-2004/0080214	04-2004	Metlitzky et al.	307/010.3
*	G	US-2004/0169993	09-2004	Nakamura, Tsuyoshi	361/643
	Н	US-			
	ı	US-			· ",
	J	US-			
	К	US-			
	L	US-			П
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 4005809 A	08-1991	Germany	VONGUTTENB et al.	
	0					
	Р					A. T
	Q					
	R					•
	S					
	Т					

NON-PATENT DOCUMENTS

	NON-I ATEN DOCUMENTO					
*	•	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	v					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.